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SESSION: Advanced Packaging I

Time: 13:10-15:10, Wednesday, Oct. 26, 2022

Chair: Chih Hang Tung, TSMC

Tz-Cheng Chiu, National Cheng Kung University

Paper Code	Topic	Lead Author	Affiliation
AS0074	A Laser Release Temporary Bonding Tape for Hybrid Bonding Having High Thermal Resistance and Excellent Thickness Uniformity1	Izumi Daido	SEKISUI CHEMICAL CO., LTD
AS0080	Nano-Artifact Metrics Chip Mounting Technology for Edge Al Device Security5	Hitoshi Masago	Waseda University
TW0086	Effects of Shielding Materials on EMI Performance for 5G Wi-Fi Applications9	Shen-Yu Yang	Wistron NeWeb Corporation
AS0037	Plasma-Activated Cu-Cu/Al-Al Direct Bonding for Electronics Packaging13	Liangxing Hu	Nanyang Technological University
TW0063	Low Thermal Budget Cu/SiO2 Hybrid Bonding Using Highly <111>-oriented Nanotwinned Cu with Low Contact Resistivity and High Bonding Strength17	Jia Juen Ong	National Chiao Tung University



SESSION: Advanced Design, Modeling & Testing I Time: 15:40-17:40, Wednesday, Oct. 26, 2022

Chair: Kuoming Chen, UMC

Chang-Chun Lee, National Tsing Hua University

Paper Code	Topic	Lead Author	Affiliation
TW0067	LAB Flip Chip Re low Process Robustness Prediction by Thermal Simulation21	Ching Ho Chang	AMKOR
TW0041	Thermal Performance of Single-Phase and Two- Phase Immersion Cooling in Data Center25	Chun-Kai Liu	Industrial Technology Research Institute
TW0004	Quantified tabbed lines and ground void impact on real DDR5 eye margin29	Dirack Lai	Intel



SESSION: Advanced Bonding and Interconnect Technology

Time: 10:00-12:00, Thursday, Oct. 27, 2022

Chair: Chih Chen, National Yang Ming Chiao Tung University

Ting-Li Yang, Mediatek

Paper Code	Topic	Lead Author	Affiliation
AS0038	The Effects of Voids on Solder Joint Reliability in First Level Interconnect32	Sze Pei Lim	Indium Corporation
TW0022	Low Temperature Fusion Bonding of Glass to Si Using Plasma Activation36	Ya-Huei Chang	Corning Incorporated
TW0106	Failure Analysis for Package of Gold Wire Bonding From Practical Case38	Huang Shan-Yu	Wistron
OT0132	Edgebond adhesive enhances reliability of low temperature solder in board level assembly42	Simon Chang	Zymet



SESSION: Fan-Out and Heterogeneous Packaging Time: 13:10-15:10, Thursday, Oct. 27, 2022

Chair: David Tarng, ASE

Shih-Kang Lin, National Cheng Kung University

Paper Code	Topic	Lead Author	Affiliation
AS0013	High Temperature Resistant Pretection Tape For Panel Level Embedded Chip Package on Substrate46	Lei Dong	3M Company
TW0058	RF Devices Integrated by Fan-Out and System-In- Package Technology50	Cheng-Yuan Kung	Advanced Semiconductor Engineering (ASE) Inc.
TW0071	A Study of Material Extraction and Moisture Effect on mmWave Fan-out Package Design54	Chiung-Ying Kuo	ASE Group



SESSION: Advanced and Green Materials and Process

Time: 13:10-15:10, Thursday, Oct. 27, 2022

Chair: Vincent Wei,iCana Limited Kuo-Chan Chiou, ITRI

Paper Code	Торіс	Lead Author	Affiliation
TW0089	A Fluorinated Electronic Grade Coating which can Help to Pass ANSI/ISA G3 Corrosion Test for Protecting Outdoor Electronics58	Dem Lee	Integrated Service Technology, Inc.
AS0024	Study on Interfacial Reaction and Tensile Properties in the C1990HP/Sn/C1990HP Sandwich Couples64	Andromeda Laksono	National Taiwan University of Science and Technology



SESSION: Advanced Design, Modeling & Testing II Time: 15:40-17:40, Thursday, Oct. 27, 2022

Chair: Sheng-Jye Hwang, National Cheng Kung University

Lewis Huang, Senju

Paper Code	Topic	Lead Author	Affiliation
EU0082	Raman Spectroscopy and Hyperspectral Imaging for Wafer-On-Wafer (WOW) Processing68	Anton Myalitsin	ANVOS Analytics Co., Ltd.
AS0097	System Level IR Drop Impact on Chip Power Performance Signoff for RISC-V System on Chip72	kin fei yong	starfive
TW0103	DDR Debug Methodology for Board Design Quality and System Robustness76	Thonas Su	Intel
TW0040	A Novel Modelling Methodology for Underfill Molding Process On 2.2D Heterogeneous Integrated Substrate80	Yu-En Liang	CoreTech Moldex3D
TW0115	Effects of Adhesive Materials on Corner/Edge Bond for Automotive SiP Applications84	Kuo-Hua Hsieh	Wistron NeWeb Corporation
TW0032	Predict the Reliability Life of Wafer Level Packaging using K-Nearest Neighbors algorithm with Cluster Analysis88	Hung-Lin Chen	National Tsing Hua University



SESSION: Advanced Materials, Automatic Process & Assembly

Time: 15:40-17:40, Thursday, Oct. 27, 2022

Chair: Dyi Chung Hu, Siplus

Fan-Yi Ouyang, National Tsing Hua University

Paper Code	Topic	Lead Author	Affiliation
TW0085	Interfacial Microstructure Evolution of Indium Jointed with Different Surface Finishes after Thermal Treatments93	Cheng-Lun Chen	Siliconware Precision Industries Co., Ltd. (SPIL)
AS0104	Cyber-Physical System of laser micro processing for semiconductor package fabrication97	Yohei Kobayashi	The University of Tokyo
AS0124	A Plasma Enhanced CVD Technology for Solving Issues on Sidewall Deposition in Trenches and Holes101	Masaharu Shiratani	Kyushu University



SESSION: Test, Quality, Inspection and Reliability Time: 15:40-17:40, Thursday, Oct. 27, 2022

Chair: Jeffrey Lee, IST

Yu-Jung Huang, I-SHOU University

Paper Code	Topic	Lead Author	Affiliation
EU0101	The impact of Sn-Oxide on the solder wetting of immersion tin and how to overcome possible solderability defects to ensure constant solder wetting performance104	Britta Schafsteller	MKS Atotech
TW0052	Robust and Accurate Measurement Methodology for High-speed Channel Electrical Characterization108	Yang Hung Cheng	MPI Corporation
TW0102	Determination of Dielectric Constant and Dissipation Factor of Printed Circuit Board by Microstrip With Ring and Straight-Line Resonator Measurements111	Chien-Chang Huang	Yuan Ze University
TW0107	Copper Surface Roughness Analysis in Numerical Morphology Algorithm for the Insertion-Loss Validation115	Li-Chi Chang	Elite Material Co.,Ltd.



SESSION: Power Electronics

Time: 10:30-12:30, Friday, Oct. 28, 2022 Chair: Albert Wu, National Central University

Chun-Kai, Liu, ITRI

Paper Code	Topic	Lead Author	Affiliation
AS0029	Impact of Via Structure Toward Wire Bond Interconnect Quality118	Kuan Fang Lee	X-FAB Sarawak Sdn. Bhd.
TW0043	Thermal Design of SiC Power Module for EV/ HEV Applications122	Chun-Kai Liu	Industrial Technology Research Institute
TW0050	The numerical study of mechanical improvement of the metal annealing process during the manufacturing of the IC backend Damascene structure126	Pei-Yun Sun	National Tsing Hua University
TW0049	Wire Boning Process Failure Risk Estimation of the Cu/low-k Structure using the Transient Finite Element130	Jing Yu Wang	Tsing Hua University



SESSION: Advanced Packaging II

Time: 10:30-12:30, Friday, Oct. 28, 2022 Chair: De-Shin, Liu, National Chengchi University CY Yang, National Central University

Paper Code	Topic	Lead Author	Affiliation
TW0134	Firewall Design for High Quality Electroplating Redistribution Layers on 600mm Panel134	Boyin Wu	Advanced Semiconductor Engineering, Inc.
TW0073	A 2x2 Broadband Dual-Polarized Antenna Array using AiP Techniques for 5G mmWave Beamforming Systems137	Stanley Hsiao	Advanced Semiconductor Engineering (ASE), Inc.
TW0015	Laser Drilling & Plasma Descum Employed In The Process of Wafer-Level Chip Scale Package(WLCSP)141	Jack Huang	E&R Engineering Coporation



SESSION: HDI, IC Substrate and FPC Technology Time: 10:30-12:30, Friday, Oct. 28, 2022 Chair: Chi-Shiung Hsi, National United University

Irving Lee, UL

Paper Code	Торіс	Lead Author	Affiliation
EU0081	Hydrogen Embrittlement Suppressors for Nickel-Free Electroless Copper Baths147	Stefanie Manuela Bremmert	MKS Atotech



SESSION: Advacned Design & Emerging Modeling

Time: 13:30-15:30, Friday, Oct. 28, 2022 Chair: Cadmus Yuan, Feng Chia University

Kuan-Jung Chung, National Changhua University of Education

Paper Code	Topic	Lead Author	Affiliation
TW0066	Using Extra Trees Machine Learning Algorithm to Predict the Asymmetric Warpage Geometry of Panel Level Packaging151	Zhen Hsu	National Tsing Hua University
TW0072	Study on Gaussian Process Regression to Predict Reliability Life of Wafer Level Packaging with cluster analysis155	Chih Yi Chang	National Tsing Hua University
TW0116	The effects of time-dependent inelastic behaviors on the debonding of Cu-polyimide interface159	Tz-Cheng Chiu	National Cheng Kung University



SESSION: Advanced Packagng Process and Design

Time: 13:30-15:15, Friday, Oct. 28, 2022

Chair: Jenn-Ming Song, National Chung Hsing University

Chien-Lung Liang, National Taiwan University of Science and Technology

Paper Code	Topic	Lead Author	Affiliation
AS0075	Adhesion and Reliability Study of Different EMC and Pre- plated Leadframe Surface Combination for Au and Cu wire bonded Leadless Package163	April Joy Garete	Nexperia
AS0025	Effect of Package Singulation Parameters on Dual Flat Non-leaded Package Delamination167	Siying Wu	Nexperia



 ${\it SESSION: Advanced Substrate/PCB \ Process \ and \ Manufacturing}$

Time: 13:30-15:30, Friday, Oct. 28, 2022

Chair: Shu Huang, ITRI John Liu, TPCA

Paper Code	Торіс	Lead Author	Affiliation
US0016	RDL Copper Plating Process for Panel Level Packaging Application171	Kesheng Feng	MacDermidAlpha Inc
AS0033	Printed Circuit Board (PCB) Routing Optimization with an Innovative Edge Connector for PCI-Express 5.0 and Beyond175	huafang ju	Intel China Ltd.



Poster session-Packaging

Time: 15:10-15:40, Wednesday, October 26, 2022 Chair: Hung-Yin Tsai, Dean, National Tsing Hua University

Hsien-Chie Cheng, Distinguished Professor, Feng Chia University

Lih Shan Chen, Professor, I-SHOU University

Paper Code	Topic	Lead Author	Affiliation
TW0002	Real time analysis for Laser drilling vias of 5G Material with Multiphoton microscopy179	Hsin Yu Chang	ITRI
TW0012	PCIe-Express Channel Design Optimization for Out-of-Guideline Three Connector Topology181	Mark Wang	Intel
TW0034	STUDY OF HIGH-TECH FACTORY DIGITAL TWIN VIRTUAL SIMULATION MODEL BASED ON INHERENTLY SAFER DESIGN STRATEGY185	Chang Kuo-chi	Fujian University of Technology
TW0039	The Study of the Influence on Heat Dissipation Effectiveness of the Pin-Fin Angle and Spacing in a Liquid Cooling Module189	WU RUO-YU	T-Global Technology
TW0045	Impedance Implementation Pattern for PCB Design194	Gary Tsai	INTEL
TW0046	Enhanced System Level Channel Characterization Methodology with Seamless Correlation among Hardware, Signal Integrity and Electrical Validation for Design Robustness197	Jimmy Hsu	Intel
AS0057	Board Design Architecture and Optimization for High-power 48V Voltage Regulator201	Shijuan Qin	Intel
TW0068	Pre-fabricated High-density TSV Interposer for Programmable IC Applications205	Tsung Yu Ou Yang	ITRI
TW0088	Measurement of Laser Drilling Shift for Opaque Build-up Film by Infrared Microscope209	Chung-Yu Ke	SPIL
AS0091	Ultrasonic dispersion of nanocomposite solder for microelectronic packaging211	Sri Harini Rajendran	University of Seoul
TW0108	Equivalent Circuit Extraction of Solder Bumps Using a Single Calibration Component for Millimeter-Wave Packaging Applications215	Liang-Yu Ou Yang	National Central University
TW0109	Establish a Rule for the selection of ion residue testing machines for different ion pollution sources217	Shih Ping Chang	Siliconware Precision Industries Co.
TW0118	Optimization fingerprint reconstruction using deep learning algorithm221	Hsiang-Chen Hsu	I-Shou University
TW0120	A Study of JEDEC Board-Level Drop Test Performance Prediction Trend of BGA Package with SAC1205 Under Different Key Factors224	Cheng ChiMin	ASE
TW0122	Multi-Chiplet Placement Design for 3D Integration228	Yu-Jung Huang	I-Shou University



Poster session-PCB

Time: 15:10-15:40, Thursday, October 27,2022

Chair: John Liu, Consultant, TPCA

Paper Code	Торіс	Lead Author	Affiliation
AS0009	Root Cause Analysis on the FCCL Delamination of Rigid Flexible Board232	CHENXI XIE	Shanghai Hesai Technology Co., Ltd
AS0010	Research on the Thermal Cycle Test Performance Improving in Automotive R-F PCB235	CHENXI XIE	Shanghai Hesai Technology Co., Ltd
TW0017	Minimize Bottom Termination Component Voids by Board Assembly Process & Design Optimization238	Kevin Hong	Universal Global Scientific Industrial Co., LTD
TW0018	Solar Cell Boost Converter with Adaptive PD Controller244	Chao-Ting Chu	CHT
TW0019	Design of Adaptive PD Controller in Digital Solar Cell Buck Converter248	Chao-Ting Chu	CHT
TW0035	INTELLIGENT EXPLOSION-PROOF GAS MONITORING AND EARLY WARNING SYSTEM WITH SEMICONDUCTOR PLANT AS DISASTER PREVENTION TARGET252	Chang Kuo-chi	Fujian University of Technology
TW0044	High-speed Data Center PCB Design Challenges and Findings by Intel Automatic In-board Characterization256	Jimmy Hsu	Intel
TW0056	Fast End-to-end Channel Electrical Characterization Methodology for Design and Manufacture Quality Check260	Tina Yang	Intel
TW0064	An Innovative Customized PCB Surface Printing for Performance Enhancement264	Ryan Chang	Intel
TW0094	Evaluation of the Impact of Low Parasitic Losses on Power Conversion PCB Design for Bio-Power Generation268	Hsing-Jen Lee	Kun Shan University